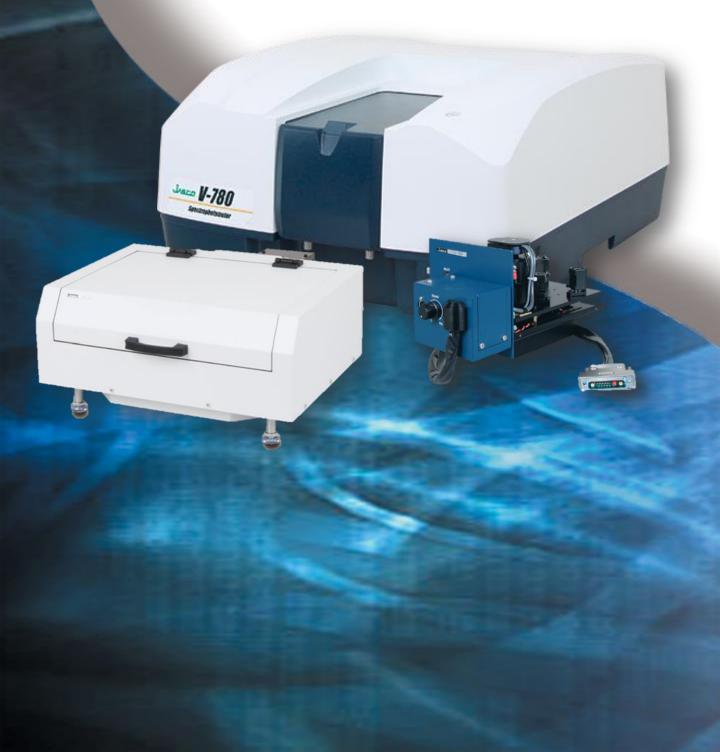


# V-780-CFR

## UV-Vis/NIR Double Beam Spectrophotometer



### **Company Presentation**



*JASCO Corporation* - Japan was founded in 1958 to provide the scientific community with optical spectroscopy products.

In the mid-1950's a group of researchers in the Institute of Optics of what is now Tsukuba University needed an Infrared Spectrophotometer for their research.

Since a commercially available instrument was not yet existing at the time, they undertook the challenge to develop their own.

The result was quite a success - a reliable instrument with excellent optical performance. As a second result, other research groups asked them to replicate the instrument for use within their laboratories.



Over the years the JASCO product line has grown to cover instruments used, not only in research but also for routine analysis applications in areas such as quality control, environmental analysis, and process control. The current spectroscopy product line encompasses instrumentation for the following methods:

- UV/Visible and NIR
- Microscope Spectrophotomers
- FT-IR, microscope FT-IR and FT-Raman
- Dispersive RAMAN
- Polarimeters
- Spectrofluorometers
- Portable Raman
- Portable FT-IR
- Fully Automated Dissolution Tester

JASCO is also the world leader in the field of *Circular Dichroism Spectropolarimeters* and *Vibrational Circular Dichroism Spectrometers*.

### "serving the Science and Technology World by providing most advanced analytical instrumentation"

With the introduction of HPLC in the mid-1970's JASCO's experience in highly sensitive and accurate optical systems led to the development of a series of chromatographic detection systems. Fixed and variable wavelength UV/Visible and Fluorescence detectors were introduced featuring excellent sensitivity and reliability in compact modules. In order to offer complete HPLC systems JASCO developed a variety of novel solvent delivery systems as well as other accessories such as column ovens, autosamplers, and PC based control and analysis software.

Today JASCO offers a wide variety of *HPLC modules*, accessories and analysis software. The new *JASCO LC-4000 Liquid Chromatography* series is designed to operate at pressures approaching 15,000 psi for either gradient or isocratic separations, providing researchers with a powerful tool when using the new generation of small particle columns. LC-4000 Series includes a versatile series of components offering unique flexibility to build systems for routine and specialized applications. LC-4000 features the widest choice of optical HPLC detector: UV, diode array, fluorescence, chemiluminescence, CD, chiral and refractive index detector.

Finally JASCO's modular **Supercritical Fluid Chromatography** and **Supercritical Fluid Extraction** platforms provide a low-cost, fast, green technology with reliable and worry-free performance for a wide variety of applications.



JASCO has a strong global presence, supplying customers in *over 45 different countries*.

## JASCO Europe



JASCO Europe is responsible for marketing, sales, service and support for all Jasco products throughout Europe, Middle East and Africa.



#### JASCO Europe S.r.l.

Via Cadorna, 1 - 23894 Cremella (LC) Tel. +39-0399215811 Fax +39-0399215835

jasco@jasco-europe.com

www.jasco-europe.com

Follow us on:

Linked in

#### Make the most of your investment with JASCO Service and Support

JASCO Service and Support agreement plans are designed for those laboratories pursuing superior productivity through the highest level of professional services.

The use of automated instrumentation is the right approach to meet today's laboratories productivity requirements, reducing analysis run times, enhancing sample throughput, and increasing analytical accuracy and precision. In this view, preventive maintenance is very important to maximize laboratory uptime and avoid unexpected expenses.

In addition to the analytical goal, proper installation and maintenance are required to achieve optimal performance. JASCO provides flexible service and support management solutions focused on your laboratory real objectives. With its service network, JASCO is ready to maintain the perfect reliability of customer's instrumentation and minimize the laboratory down time.

- · Superior productivity
- · Optimized analytical performance
- · Lower cost of ownership
- · Extended instrument life

If your laboratory has specific Service and Support requirements, JASCO can help you with customized contract agreements. In addition, a full set of Installation Qualification (IQ), Operational Qualification (OQ), and Performance Qualification (PQ) tests are available to verify the system proper installation, operation and performance, respectively.

#### Get the most from your investment with JASCO Training Courses

JASCO Training Courses ensure maximum skill development for the best value of your laboratory. Our team of highly-experienced specialists can help your staff to get the most from your instrument reducing your analysis run time and improve performance.

Build your knowledge with JASCO Training Courses:

- Instrument and Software operation
   troubleshooting
- Maintenance
- · Calibration
- · Applications and Methods developments
- · Operating Techniques



### V-780-CFR Spectrophotometer

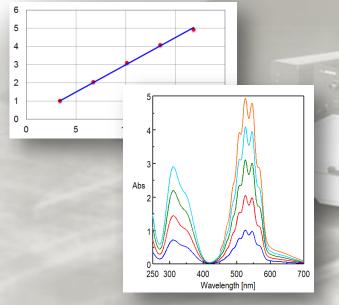


#### UV-Vis/NIR Spectrophotometer V-780-CFR

V-780-CFR JASCO is а double beam spectrophotometer with а single monochromator and double detector system and InGaAs). V-780-CFR has (PMT been specifically design to achieve the highest sensitivity and resolution in NIR region up to 1600 nm. V-780-CFR supports various optional accessories for liquids and solids, providing sample measurements for a wide variety of sample shapes and volumes.

#### JASCO V-780-CFR KEY FEATURES

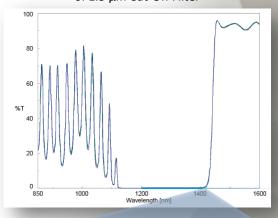
**High photometric linearity** - The photometric linearity range is up to 5 Abs in the visible region, up to 4 Abs in the UV-Visible region and up to 3 Abs in the NIR region. V-780-CFR offers measurement with a wide dynamic range and high-absorbance by employing optimized high-order cut-off filters, ultra high-resolution A/D converter and simplified signal processing prior to the A/D conversion.

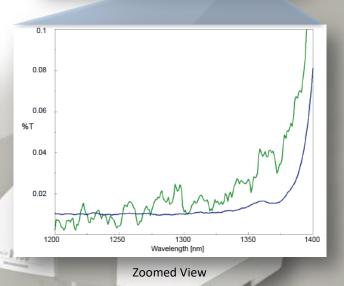


Excellent linearity up to 5 absorbance using KMnO4 solution

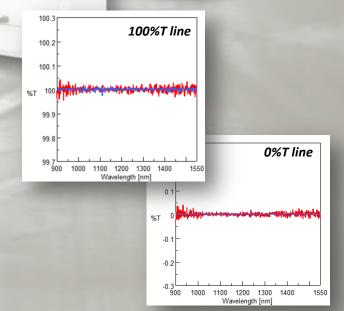
**High sensitivity in the NIR region** - The figures compare a 1.3 μm band cut-off filter for optical communication measured using a spectrophotometer with a Peltier-cooled PbS photo-conductive detector and the JASCO V-780-CFR with a Peltier-cooled InGaAs Photodiode detector.

Transmittance Spectra of 1.3 μm Cut-Off Filter





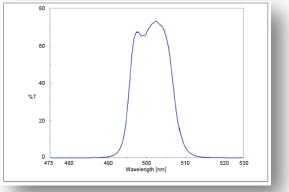
The InGaAs detector offers significant S/N enhancement over the PbS detector. Here below S/N ratio with 60 mm Integrating Sphere



InGaAs photodiode (JASCO V-780-CFR) PbS photocell

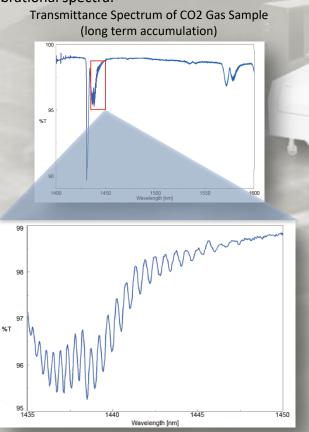


**Step-scan measurement** - Step-scan is a very useful tool for accurate measurement of samples such as bandpass filters for which the transmittance changes significantly over a narrow wavelength range.



Transmittance Spectrum of Bandpass Filter

**High resolution in the NIR-** The figure below is the vibrational spectrum of CO2 gas (path length: 100 mm) in the NIR, measured using the V-780-CFR. Overtones are seen near 1430 nm and also combination bands near 1770 nm. Zooming into the spectrum at around 1437 nm shows that the V-780-CFR offers sufficient resolution to see the rotational peaks in the vibrational spectra.

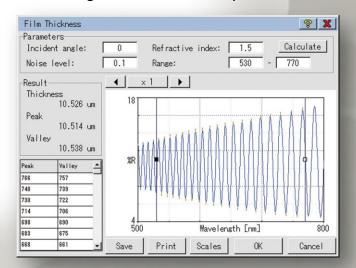


Zoomed View

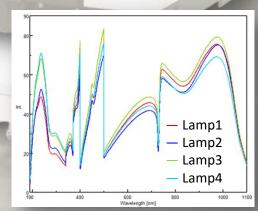
### V-780-CFR Spectrophotometer

Film thickness measurement - Film thickness measurements can be made using the SLM-907 specular reflectance accessory and integrated as standard Film Thickness measurement program.

The film thickness of a food packaging film using the SLM-907 single reflection accessory is shown below.



Alignment-free lamp replacement - The design of the socket deuterium lamp and socket tungsten halogen lamp facilitates light source over replacement, simplifies maintenance and reduces operation error. In the example below, single beam spectra and validation results of 4 different lamps mounted without any alignment tools.

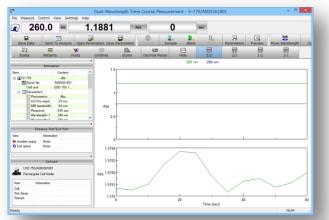


	Lamp 1	Lamp 2	Lamp 3	Lamp 4
Wavelength Accuracy	Pass	Pass	Pass	Pass
Photometric Accuracy	Pass	Pass	Pass	Pass
Noise Level	Pass	Pass	Pass	Pass
Baseline Flatness	Pass	Pass	Pass	Pass

## V-780-CFR Spectrophotometer



**Dual wavelength time course measurement** - kinetics measurement can be performed by simultaneous dual wavelength, and the difference between dual photometric value and the ratio of dual photometric value can be plotted.



**Dark Correction** - A Dark Correction function is standard for all models of the V-700 Series, which provides photometrically accurate measurements of highly absorbing samples.

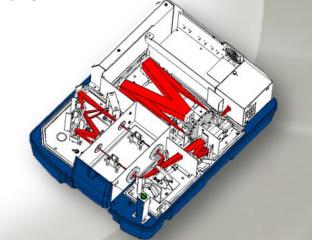
#### **Energy and space-saving system**

- Green technology, best energy-saving in its class Switch off the light source from the measurement screen when not in use.
- Save energy and lamp life.
- All models have the most compact design requiring minimal bench space.

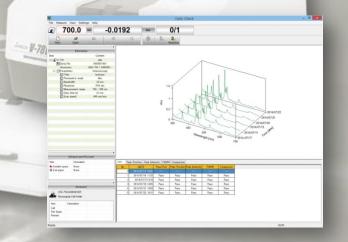
**Validation** - V-780-CFR provides a standard validation program. This program supports USP, EP and JP instrument qualification requirements. The program automatically performs an analysis of the instrument results based on defined acceptance criteria. Results of the validation tests can be printed or saved electronically for further review.



**True Double-Beam spectrophotometer** - All JASCO V-700 spectrophotometers are true double-beam systems, provide the best possible stability and allow reference to be measured and corrected in real time.



Daily check program - For users who requires a regular validation check; use a simple Holmium glass filter other standard) (or for dailv measurement with automatic execution of procedures easily record and track to а comprehensive history of instrument performance.



**IQ** accessory and **IQ** Start - The IQ Accessory function automatically recognizes an accessory when it is inserted into the sample compartment. When the IQ Accessory system recognizes the registered accessory, the assigned program automatically starts by using the IQ Start function.

**Start Button** - All models have a Start Button for immediate initiation of sample measurement. After placing a sample in the sample compartment, simply press the Start Button on the instrument to begin measurement.





## JASCO V-780-CFR Unique Features

- Standard working range (**190** to **1600** nm) and variable spectral bandwidth from **0.1** nm enough to satisfy any requirements.
- Outstanding RMS noise (0.00003 Abs) and Dynamic Range (5 Abs) provide capabilities from education and routine analysis to high-end research applications.
- **Double detector system** (PMT and **InGaAs**) able to achieve the highest sensitivity and resolution in NIR region.
- The 'L' Mode and 'M' mode spectral bandwidth settings for measurement of highly absorbing samples or for accurate measurements of trace amounts of sample in a micro cell.
- **True Double-Beam** spectrophotometer provides the best possible stability and allows reference to be measured and correct on real time.

- **IQ Accessory function** for automatic recognition of any accessory inserted into the sample compartment.
- Validation and Daily Check programs help operator to keep the instrument always in perfect conditions assuring maximum accuracy of obtained results.
- The V-700 Series can be integrated with more than 70 accessories and over 30 optional programs to offer flexible configurations for a wide variety of analytical requirements.
- Cross-platform software package **Spectra Manager CFR** provides features to support laboratories for compliance with **21 CFR Part 11**.

JASCO SPECTRA MANAGER II



#### Software JASCO SPECTRA MANAGER II

The SPECTRA MANAGER II program is a comprehensive package for capturing and processing data, eliminating the need to learn multiple software packages and offering the user a shallower learning curve. Several types of measurement data files can be viewed in a single window, and processed using a full range of data manipulation functions.

The basic package includes:

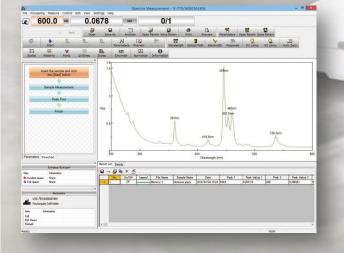
QUICK START MEASUREMENT PROGRAM - The Quick Start Measurement Program can automatically perform a series of operations as specified by a user, from measuring samples and processing data to saving and printing results, with a single click of the start button. The procedure is stored in memory for repeated use. processing functions The data include comparison of an obtained spectrum with spectra specified by a user.

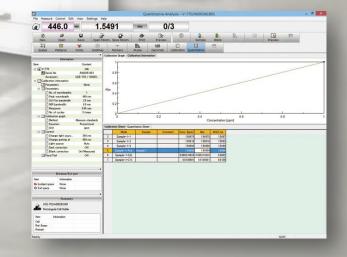
**SPECTRA MEASUREMENT PROGRAM** - The Spectra Measurement program measures photometric values of a sample in the selected wavelength range. Abs, %T or %R are available for the vertical axis while nm, cm-1,  $\mu$ m, and eV are available for the horizontal axis.

**CANVAS PROGRAM** - JASCO Canvas Program allows the user to prepare publication quality layouts of spectra, measurement parameters, text, images (BMP and WMF formats) to meet the user's own report requirements. The program also includes a set of drawing tools for professional documentation. Newly created documents can be stored as templates for routine data presentation.

VALIDATION PROGRAM – The Validation program offers assistance for verifying instrument performance to meet regulatory requirements set by GxP. The test methods are compliant with USP, EP and JP procedures. The program includes validation tests for wavelength accuracy, wavelength repeatability, photometric accuracy, photometric repeatability, resolution, resolution power, stray light, noise level, baseline stability and baseline flatness. Optional standards and tools are required for some validation tests.

**QUANTITATIVE ANALYSIS PROGRAM** - The quantitative measurement package consists of two programs; a calibration curve creation program and a quantitative measurement program. The program provides three types of baseline correction methods and eight types of calibration curves. A function for providing a pass/fail judgement for the obtained values is included.





## JASCO SPECTRA MANAGER II



#### Software JASCO SPECTRA MANAGER II

**FIXED WAVELENGTH PROGRAM** - The Fixed Wavelength measurement program measures the photometric values of up to eight multiple wavelengths. A 'cycle number' and 'wait time' are selectable, and the mean, standard deviation and C.V. value for each wavelength are displayed after completion of each cycle of sample measurements.

**SPECTRUM PREVIEW FUNCTION** - The spectrum preview function allows a user to monitor changes to a spectrum by varying parameters in real-time. A spectrum can be rapidly obtained using the maximum scanning speed available. This function allows verification of the optimum set of instrument parameters and to check sample conditions before actual measurements.

**TIME COURSE PROGRAM** - The Time Course measurement program measures the changes of a sample's photometric value over time at a fixed wavelength and with a defined interval. For the time course measurement, the V-780-CFR can obtain data at a minimum interval of 0.05 sec. Parallel time course measurements while controlling the cell positions of a cell changer are also possible.

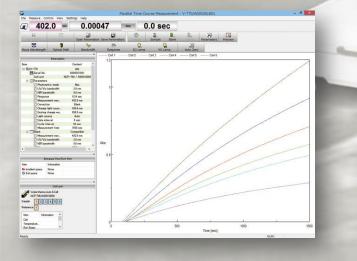
**SPECTRA ANALYIS PROGRAM** - The spectra analysis program includes all typical data analysis and data manipulation functions.

Furthermore, the film thickness measurement, color analysis, and the enzyme activity calculation programs are provided as standard.

#### **Data manipulation functions**

- Spectral manipulations (zoom in, zoom out, rescale)
- Overlay
- Arithmetic operations
- Spectral Subtraction
- Derivatives
- Peak detection and processing Find, Height, Area, FWHH
- Smoothing
- FFT Filter
- Deconvolution
- Baseline correction
- Unit conversion

**AUTOMATIC SETUP** - The response time is automatically determined depending on the selected bandwidth and scan speed so that the spectrum profile does not become broad. The data interval is also automatically determined depending on the selected bandwidth.



Photometr	ic mode:	Abs	~			
Bandwidth	r:	2.0 nm	~	NIR bandwidth:	8.0 nm	$\checkmark$
Response		0.06 sec	$\sim$	NIR response:	0.06 sec	$\vee$
Start:		800	nm			
End		200	nm			
Data inter	val:	0.5 nm	$\sim$			
Scan mod	e:	Continuou	s v			
Scan spee	ed:	1000 nm/r	min 👻			
				Accumulation/cy	cle	
				Accumulation	n	
Vertical :		• 0		No. of cycles:	1	

Spectra Manager - CFR features



#### Software JASCO SPECTRA MANAGER II - CFR

Spectra Manager CFR provides features to support laboratories for compliance with **21 CFR Part 11**. A choice of complete pull-down task menus, user-friendly icons, and easily accessible pop-up menus enables new users to manage security information, control user access, and record audit trails.

#### The package includes:

- Access control for secure systems by user ID and password
- Audit trail function with time-stamp for records tracking
- Three levels of electronic signatures for record integrity

#### Easy-to-use

Startup window lists available resources, such as instruments, measurement and application programs.

#### User registration

All users who use Spectra Manager CFR must be registered. When registered, the user must be assigned specific access levels for administrative rights and access to control and analysis programs.

New Us	er	×	
	Username:		
	Full Name:		-
	Division:		
	Access Level:	•	
	Password:		C. Same
	Confirm Password:		
	OK Cancel		

#### System policy

Password expiration, the minimum number of characters and timeout for password entry can be set by authorized managers.

#### Access rights control

User access to the Spectra Manager CFR requires a Username and Password.

#### Security management

All of the security management functions of Spectra Manager CFR are accessed through the Administrative Tools interface.

#### Workgroup registration

Users who perform measurements and analyses must be registered in a workgroup. Within a workgroup, users are granted access as either a "Manager", "Analyst", or "Operator", with authorities to modify instrument and analysis settings. Individual users are only able to execute procedures that are allowed by their assigned access level.

General Registered Users		kgroup Folder	General Registered Users	Workgroup Folder Registered Instruments and Application
Username Administrator Ben Chuck Dave Ø Richard Ø Trish	Full Name Administrator Ben Landas Chuck Higgins David Emplit Richard A. Larsen Patricia A. Larsen	Workgroup Rights Managers Operators	Instrument       Image: State of the state	ab stion ivas
•	OK Can	cel Apply		IK Cancel Apply

#### Audit trails

The system and application history are automatically recorded. Audit trails are assigned to every data file, recording data manipulations on the spectral data. Audit trails are also applied to instrument parameters, Canvas templates or documents and analysis methods.

Administrative Tools Operation View Help	,							-	
Administrative Tools	Calegory	Date and Time	Description	Extra Information	User	Wokgoup	Instument	Application	
System Policy	Information	11/25/2003 2:17:06 PM	Disconnection		Richard	Jacco QC	QCA Lab		
🖻 🖉 Instrument	Nomal 8	11/25/2003 2:17:50 PM	Stating up Analysis Application		Triph	Jacco QC		JASCO Canvas	
Analysis Application	Nomal 1	11/25/2003 2:17:50 PM	Open Data	C:\ArkvQC\template\RALQCAVol5.jct	Trish	Jasco QC		JASCO Canvas	
🖃 🚮 User Control	Information	11/25/2003 2:19:09 PM	Quit Analysis Application		Trish	Jasco QC		JASCO Canvas	
E G Log Management	Nomai 💀	11/25/2003 2:19:28 PM	Stating up Analysis Application		Richard	Jasco QC		JASCO Canves	
System	Nomai 8	11/25/2003 2:19:28 FM	Open Data	C:VArk+QCWemplate/RALQCAVol5.jct	Richard	Jacco QC		JASCO Canves	
Application	Nomai 8	11/25/2003 2:20:19 FM	Save Data	C:VArk+QCVenplate1RALQCAVol6.jct	Richard	Jacco QC		JASCO Canvas	
System Information	Information	11/25/2003 2:20:28 PM	Quit Analysis Application		Richard	Jacco QC		JASCO Canvas	
Warkgroup	Nomal 1	11/25/2003 2:20:58 PM	Stating up Analysis Application		Richard	Jasco QC		Spectra Analysis	
	Nomal 1	11/25/2003 2:20:58 PM	Open Data	C:\ArkvQC\QCAVoH37.jws	Richard	Jasco QC		Spectra Analysis	
Jesco QA	Nomai 🛛	11/25/2003 2:21:08 PM	Connection		Richard	Jasco QC	QCA Lab		
- 🚰 Jasco QC	Nomai 8	11/25/2003 2:21:08 FM	Starting up Measurement Application		Richard	Jacco QC	QCA Lab	Spectra Measurement	
	8 Nomai	11/25/2003 2:21:08 FM	Open Measurement Conditions	C:VArkvQCVaccoQCA3.par	Richard	Jacco QC	QCA Lab	Spectra Measurement	
	Nomal 8	11/25/2003 2:28:55 PM	Save Measurement Conditions	C:VArk+QCVaccoQCA3.par	Richard	Jacco QC	QCA Lab	Spectra Measurement	
	Nomal 1	11/25/2003 2:28:58 PM	Edit Measurement Conditions	Measurement Range	Richard	Jasco QC	QCA Lab	Spectra Measurement	
	Nomal 1	11/25/2003 2:29:06 PM	Stating Measurement	Background	Richard	Jasco QC	QCA Lab	Spectra Measurement	
	Nomai	11/25/2003 2:29:12 PM	Measurement ended	Background	Richard	Jasco QC	QCA Lab	Spectra Measurement	
	Nomai 8	11/25/2003 2:29:23 PM	Stating Measurement	Sanple	Richard	Jasco QC	QCA Lab	Spectra Measurement	
	8 Nomai	11/25/2003 2:29:34 FM	Save Data	C:VArkvQCVQCAVol-38.jws	Richard	Jacco QC	QCA Lab	Spectra Measurement	
	Nomal 8	11/25/2003 2:29:35 PM	Measurement ended	Sanple	Richard	Jacco QC	QCA Lab	Spectra Measurement	
	Nomal 1	11/25/2003 2:32:29 PM	Open Data	C:\ArkvQC\QCAVoF14.jws	Richard	Jasco QC		Spectra Analysis	
	Nomai	11/25/2003 2:33:03 PM	Open Data	C:VArkvQCVQCAVoF3.jws	Richard	Jasco QC		Spectra Analysis	
	Nomai 🔁	11/25/2003 2:33:15 PM	Open Data	C:VArkvQCVQCAVoF5.jws	Richard	Jasco QC		Spectra Analysis	
	Information	11/25/2003 2:48:39 PM	Quit Analysis Application		Richard	Jasco QC		Spectra Analysis	
	Information	11/25/2003 2:48:40 PM	Quit Measurement Application		Richard	Jaeco QC	QCA Lab	Spectra Measurement	
	Infomation	11/25/2003 2:48:42 PM	Disconnection		Richard	Jacco QC	QCA Lab		

#### **Electronic signatures**

Three levels of electronic signatures, "Creation", "Review" and "Approval" are available. Electronic signatures are applied to spectral data files, Canvas templates or documents, instrument parameters and analysis methods.



## V-780-CFR - Technical Specifications

Optical System	<ul> <li>Czerny-Turner mount</li> <li>Single Monochromator</li> <li>True Double-Beam (Sample &amp; Reference)</li> </ul>
Light Source	Deuterium & Halogen lamps with automatic switching
Detector	Photomultiplier tube and Peltier cooled InGaAs photodiode
Wavelength Range	190 – 1600 nm
Wavelength Accuracy	± 0.3 nm at 656.1 nm ± 1.0 nm at 1.312.2 nm
	± 0.05 nm (UV-Vis) ± 0.1 nm (NIR)
Scanning Speed	10 to 4,000 nm/min (up to 8,000 in preview mode)
	12,000 nm/min (UV-Vis) 24,000 nm/min (NIR)
Spectral bandwidth	UV-Vis 0.1, 0.2, 0.5, 1, 2, 5, 10 nm - L2, L5, L10 nm - M1, M2 nm NIR 0.2, 0.4, 1, 2, 4, 8, 20 nm – L4, L10, L20 nm – M2, M4 nm
	-4 + 4 Abs (UV-Vis) -3 + 3 Abs (NIR)
Maximum Photometric Range	-5 + 5 Abs (KMnO <sub>4</sub> aqueous solution)
Photometric Accuracy	±0.0015 Abs (0 to 0.5 Abs) ±0.0025 Abs (0.5 to 1 Abs) ±0.3 %T Tested with NIST SRM 930
Stray Light	1 % (198 nm KCl 12 g/L) 0.005 % (220 nm Nal 10 g/L) 0.005 % (340 nm and 370 nm NaNO2 50 g/L) 0.04 % (1420 nm H2O)
Baseline stability	±0.0003 Abs/hour
Baseline flatness	±0.0002 Abs
RMS noise	0.00003 Abs (0 Abs, 500 nm, 60 sec)
Communication	USB
Automatic Accessories Recognition	YES
	<ul> <li>Spectra Manager II including the following programs:</li> <li>Spectra Measurement</li> <li>Quantitative analysis</li> <li>Fixed Wavelenght</li> <li>Dual Wavelenght Time Course Measurement</li> <li>Quick Start Measurement</li> <li>Canvas</li> <li>Validation &amp; Daily Check</li> <li>Spectrum Preview</li> <li>Film Thickness</li> <li>Color</li> <li>Enzyme Activity Calculation</li> </ul>
Dimensions and weight	460(W)x602(D)x268(H) mm – 29 kg
Power requirements	150VA



## Software & Sampling Accessories V-780-CFR UV-Vis Spectrophotometer





#### Sampling Accessories

V-700 Series can be integrated with a complement of more than 70 accessories to offer flexible configurations for a wide variety of analytical requirements.

Experimental capabilities range from simple educational applications and routine daily use, to specific applications for advanced biochemical and semiconductor research.

The range of accessories include various types of cell holders for liquid samples and options for a wide variety of solid samples.

#### LSE-701 - Long path cell holder

#### **Specifications Rectangular cell** Sample Cell pathlength 10, 20, 50 or 100 mm Rectangular cell **Reference Cell** pathlength 10, 20, 50 or 100 mm Capacity 1 sample and 1 reference cell **Temperature** Ambient VWAC-796 - ASTM Color analysis program • Suggested VWSC-797 - Saybolt color analysis program • VWWQ-953 - Chromaticity/Turbidity Software measurement program

## FSE-702 - 4-position manual long path cell changer

et i		
	Specifications	
Sample Cell	Rectangular cell pathlength 10, 20, 50 or 100 mm	
Reference Cell	Rectangular cell pathlength 10, 20, 50 or 100 mm	
Capacity	4 sample and 1 reference cell	
Temperature	Ambient	

ot o				
	Specifications			
Sample Cell	Rectangular cell pathlength 10 mm			
Reference Cell	Rectangular cell pathlength 10 mm			
Capacity	6 sample and 1 reference cell			
Temperature Ambient				

SSE-704 - 6-position manual cell changer

#### NCP-705 - 6-position automatic cell changer

Specifications				
Sample Cell	Rectangular cell pathlength 10 mm			
Reference Cell	Rectangular cell pathlength 10 mm			
Capacity	6 sample and 1 reference cell			
Temperature	Ambient			
Cell Switching	Software Controlled			
Suggested Software	<ul> <li>VWIS-957 - Interval scan measurement program</li> <li>VWIS-958 - Temperature interval scan measurement program</li> </ul>			

#### CYH-708 - Cylindrical cell holder

	Specifications
Sample Cell	Cylindrical cell pathlength 10, 20, 50 or 100 mm
Reference Cell	Cylindrical cell pathlength 10, 20, 50 or 100 mm
Capacity	1 sample and 1 reference cell
Temperature	Ambient



#### UCB-710 – Bio rectangular cell holder



#### **Specifications**

**Specifications** 

A cell height adjustment function provides the ability to use a 100  $\mu$ L micro cell. A mask for a 100  $\mu$ L micro cell is standard, 50  $\mu$ L can be supplied as option.

Sample Cell	Rectangular cell pathlength 10 mm	
Reference Cell	Rectangular cell pathlength 10 mm	
Capacity	1 sample and 1 reference cell	
Temperature	Ambient	
Minimum Cell Volume	50 μL	

# EMC-709 – Micro cell holder



#### **Specifications**

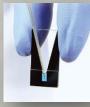
The EMC-709 is a cell holder for a 50  $\mu L$  micro cell. A 5  $\mu L$  micro cell can be used with an optional spacer.

Sample Cell	Rectangular cell pathlength 10 mm
Reference Cell	Rectangular cell pathlength 10 mm
Capacity	1 sample and 1 reference cell
Temperature	Ambient
Minimum Cell Volume	5 μL

#### EMC-759 – Ultra-micro cell holder



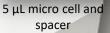
The EMC-759 is a cell holder for a 5 $\mu\text{L}$ micro cell		
Rectangular cell pathlength 10 mm		
Rectangular cell pathlength 10 mm		
1 sample and 1 reference cell		
Ambient		
5 μL		







50 μL micro cell



TCH-703 – 8-position Micro turret cell holder



-1-780

#### **Specifications**

Cell holder for an optional 8-position turret micro cell, containing eight cells with a volume of approximately 4  $\mu$ L arranged in a circle.

Sample Cell	pathlength 1 mm	
Capacity	8 sample cells	
Temperature	Ambient	
Cell Volume	4 μL	

8-position micro turret cell P/N: 6916-4822A



5 µL micro cell



The following cell holder accessories can be used with water circulators for maintaining samples at a uniform temperature. The circulators available separately.

#### STR-773 Water thermostatted cell holder with stirrer



#### HMC-711 Water thermostatted micro cell holder



#### **Specifications**

Minimum sample volume is 50  $\mu$ L by using a rectangular cell, 5 mm path length and 2 mm path width.

Sample Cell	Rectangular cell 10 x 10 or 5, 2 or 4 x 10, 2 x 5 mm		
Reference Cell	Rectangular cell 10 x 10 or 5, 2 or 4 x 10, 2 x 5 mm		
Capacity	1 sample and 1 reference cell		
Temperature Control	Thermostatted water circulation for sample and reference		
Operating Temperature	10 to 90 degC		
Cell masks (standard)	<ul> <li>Mask for 100 μL cell (2 pcs.) for micro cell, 2 x 10 mm</li> <li>Mask for 200 μL cell (2 pcs.) for micro cell, 4 x 10 mm</li> </ul>		

NCP-706 Water thermostatted 6-position automatic cell changer

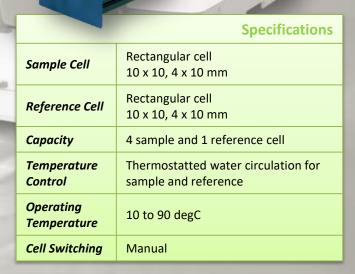


	Specifications
Sample Cell	Rectangular cell 10 x 10 or 5, 2 or 4 x 10, 2 x 5 mm
Reference Cell	Rectangular cell 10 x 10 or 5, 2 or 4 x 10, 2 x 5 mm
Capacity	6 sample and 1 reference cell
Temperature Control	Thermostatted water circulation for sample and reference
Operating Temperature	10 to 90 degC
Cell Switching	Software Controlled

posifications

#### **MHT-745**

Manual 4-position water thermostatted turret cell holder





EHCS-760 Peltier thermostatted single cell holder (Air cooled)

#### ETCS-761 & ETCR-762 Peltier thermostatted single cell holder (Water cooled)



	Specifications
Sample Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm
Reference Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm
Capacity	1 sample and 1 reference cell
Temperature Control	Sample only - Heating/cooling system using air cooled Peltier effect
Operating Temperature	10 to 60 degC (at 25 degC)
Temperature control accuracy	$\pm 0.1$ degC (cell holder sensor)
Temperature Accuracy	With cell holder sensor ±0.5 degC (20 to 40 degC) ±1 degC (other temp. range) With optional temperature sensor ±0.2 degC
Stirrer	Integrated variable speed magnetic stirrer - 2 mm path width micro cell cannot be used with the stirrer
Suggested Software	<ul> <li>VWIS-958 - Temperature interval scan measurement program</li> <li>VWTP-959 - Temperature Gradient measurement and DNA melting analysis program</li> </ul>

#### CSP-909 Lid for sample compartment with syringe port

#### **Specifications**

When monitoring a substrate-enzyme reaction, this accessory allows addition of an enzyme solution without opening the sample chamber lid. Can only be used with a 10 x 10 mm rectangular cell. Required needle length for the syringe is 50 mm

Compatible Cell	STR-733
Holder	EHCS-760 - ETCS-761 - ETCR-762
Syringe	P/N 0507-0220 – Micro syringe 10μL P/N 0507-0223 – Micro syringe 100μL





	Sample Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm		
	Reference Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm		
	Capacity	1 sample and 1 reference cell		
	Temperature Control ETCS-761	Sample only Heating/cooling system using Water cooled Peltier effect		
	Temperature Control ETCR-762	Sample & Reference Heating/cooling system using Water cooled Peltier effect		
	Operating Temperature	0 to 100 degC for cooling water temperature at 25 degC		
1	Temperature control accuracy	$\pm 0.1$ degC (cell holder sensor)		
	Temperature Accuracy	With cell holder sensor ±0.5 degC (20 to 40 degC) ±1 degC (other temp. range) With optional temperature sensor ±0.2 degC		
	Stirrer	Integrated variable speed magnetic stirrer - 2 mm path width micro cell cannot be used with the stirrer		
	Suggested Software	<ul> <li>VWIS-958 - Temperature interval scan measurement program</li> <li>VWTP-959 - Temperature Gradient measurement and DNA melting analysis program</li> </ul>		

#### Options

**Cell Mask kit** - includes sample masks and a cell-height adjustment stand to raise the cell height. Using the cell-height adjustment stand, a 2 mm path width micro cell can be used to measure sample with a minimum 100  $\mu$ L volume.

**OPS-515** - In-cell sensor with holder (factory option) - This is an optional sensor which can be used to monitor the temperature inside of the sample cell.

**Cell Spacers** - Spacers for cells with an optical path length of 1, 2 and 5 mm are available.

**Capillary adapter -** The capillary adapter is used for a capillary cell (minimum sample volume of 3  $\mu$ L). The optional sensor (OPS-515) in the cell adapter is required for temperature monitoring.



PSC-763

Automatic 6-position Peltier cell changer

(Air cooled)

## V-780-CFR – Liquid Sample Accessories

#### PAC-743 & PAC-743R Automatic 6/8-position Peltier cell changer (Water cooled)

	Specifications
Sample Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm
Reference Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm
Capacity	6 sample and 1 reference cell
Temperature Control	Sample only - Heating/cooling system utilizing air cooled Peltier effect
Operating Temperature	10 to 70 degC (at 20 degC)
Temperature control accuracy	$\pm$ 0.1 degC (cell holder sensor)
Temperature Accuracy	With cell holder sensor ±0.5 degC (20 to 40 degC) ±1 degC (other temp. range) With optional temperature sensor
	$\pm 0.2 \text{ degC}$
Stirrer	Integrated variable speed magnetic stirrer - 2 mm path width micro cell cannot be used with the stirrer
Suggested Software	<ul> <li>VWIS-958 - Temperature interval scan measurement program</li> <li>VWTP-959 - Temperature Gradient measurement and DNA melting analysis program</li> </ul>
	Options

	1		
	Specifications		
Sample Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm		
Reference Cell	Rectangular cell 10 x 10, 4 x 10, 2 x 10 mm		
Capacity	6/8 sample and 1 reference cell		
Temperature Control PAC-743	Sample only Heating/cooling system utilizing Water cooled Peltier effect		
Temperature Control PAC-743R	Sample & Reference Heating/cooling system utilizing Water cooled Peltier effect		
Operating Temperature	0 to 100 degC (at 20 degC)		
Temperature control accuracy	$\pm 0.1$ degC (cell holder sensor)		
Temperature Accuracy	With cell holder sensor $\pm 0.5$ degC (20 to 40 degC) $\pm 1$ degC (other temp. range)		
Stirrer	Integrated variable speed magnetic stirrer - 2 mm path width micro cell cannot be used with the stirrer		
Suggested Software	<ul> <li>VWIS-958 - Temperature interval scan measurement program</li> <li>VWTP-959 - Temperature Gradient measurement and DNA melting analysis program</li> </ul>		

Specifications

**OPS-513** - In-cell sensor with holder (factory option) - This is an optional sensor which can be used to monitor the temperature inside of the sample cell.

## MCB-100 Mini Water Circulation Bath



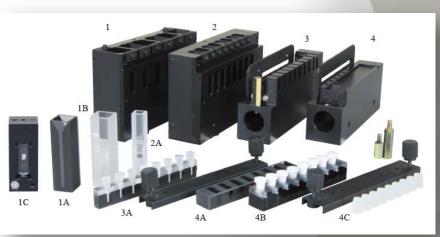
	Specifications
Temperature control range	10 degC below ambient temperature to 40 degC (IN and OUT connected)
Bath capacity	Approx. 200 mL
Temperature sensor accuracy	$\pm 0.2 \text{ degC}$ (at 20 degC)
Cooling/heating capacity	52W
Dimensions	160 (W) \x 278 (H) x 225 (D) mm
Suggested accessories	ETCS-761 – ETCR-762 – PAC-743



#### PAC-743 & PAC-743R

PAC-743 & PAC-743R allow measurements of the transmittance & absorbance of multiple samples by using dedicated cell blocks with temperature control.

The PAC-743R provides temperature control of the reference cell in addition to temperature control of the sample cells.





#### How to configure it

Cell block (Cell and temp. sensor are optional)	#	Compatible Cell	#	In-cell sensor (factory option)
		Rectangular quartz cell, 2 x 10 mm, max. 6pcs.	1A	
<b>6916-H243A</b> - 6-position cell block		Rectangular quartz cell, 4 x 10 mm, max. 6pcs.		CO1C UF1CA Concertin coll 1 no
(with variable speed magnetic stirrer) 1 for rectangular cell, 10 x 10 mm	1	Rectangular quartz cell, 10 x 10 mm, max. 6pcs.	1B	6916-H516A Sensor in cell, 1 pc. 6916-H517A Sensor in cell, 6 pcs/set
		<b>6916-H360A</b> - Capillary cell adaptor and Capillary cell, max. 6 pcs. (A sealing compound is required for using capillary cells.)	1C	
<b>6916-H343A</b> - 8-position cell block (with variable speed magnetic stirrer) for rectangular cell, 5 x 5 mm	2	Rectangular quartz cell, 5 x 5 mm, max 8 pcs.	2A	6916-H516A Sensor in cell, 1 pc. 6916-H518A Sensor in cell, 8 pcs/set
<b>6916-H643A</b> - 1 mm 8-position micro cell block (Including Silicon cap x 8, Silicon cap with sensor hole x1, and cap fixture) *Stirrer function is not available	3	<b>1103-1171A</b> - 8-position 1 mm micro cell 1 mm path length, 10 μL for each position	ЗA	<b>6916-H516A</b> Sensor in cell, 1 pc. *The 8th cell position is used only to monitor cell block temperature.
		<b>1103-0202A</b> - 8-position 10 mm micro cell 10 mm path length, 100 μL for each position without capability for well caps	4A	N/A
<b>6916-H743A</b> - 10 mm 8-position micro cell block *Stirrer function is not available	4	<b>1103-1168</b> - 8-position 10 mm micro cell with Teflon caps 10 mm path length, 100 μL for each position	4B	
		<b>6916-H543A</b> - Silicon cap kit for 1103-1168, to prevent volatilization of samples at high temperatures consisting of silicon cap x8, Silicon cap with sensor hole x1, and cap fixture	4C	6916-H516A Sensor in cell, 1 pc. *The 8th cell position is used only to monitor cell block temperature.



#### SAH-769 One drop accessory



#### **Specifications**

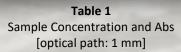
The SAH-769 One Drop accessory is a dedicated accessory for the V-700 Series to measure micro volume samples of protein and nucleic acid. The 1mm and 0.2 mm cells are included as standard with accessory.

	Minimum Sample Volume
1mm pathlenght	5 μL
0.2mm pathlenght	0.6 μL

#### Precision of Quantitative Analysis

Solutions of Calf Thymus DNA (KH2PO4 / NaOH buffer at pH7) at several concentrations were measured by using cells with 1-mm. The spectrum has shown at Figure 1 and LDL has shown at Table 1.

Table 1	Sample Conc. and Abs [OP: 1mm]		
Legend	Conc. [ng/µL]	Abs	
_	0	0.0005	
_	13	0.0228	
	26	0.0417	
_	52	0.0838	
_	260	0.4500	
-	520	0.8970	
_	780	1.3443	
-	1040	1.8137	



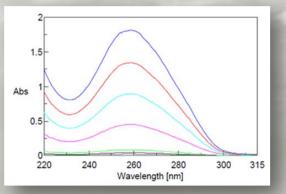
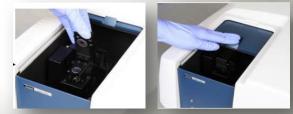


Figure 1 Absorbance spectra of DNA solution [optical path: 1 mm]

#### **Measurement Procedure**



1) Drop sample on the cell



2) Close the cover glass and the lid of sample compartment

3) Start sample measurement



4) Cleaning the cell

less than **20 seconds** 

#### Measurement Parameters Data interval: 0.5 nm

1-780

Measurement range: 220 to 315 nm Band width: 1.5 nm Response: Medium Scan Speed: 200 nm/min

More information on Application UV-0018-E



ASU-800 autosampler, combined with a syringe pump and a flow cell or a variety of sippers, automatically measures multiple liquid samples using spectrophotometer V-700 series. Tubes or tube racks according to the sample volume and the amount of samples, or dedicated racks for microplates can be purchased separately. PC control software is included as standard.

**ASU-800** can be coupled with the following accessories:

- NQF-781 Vacuum sipper
- NQF-783 Vacuum sipper with long-path flow cell
- NPF-721 Peristaltic sipper
- ASP-849 Syringe pump
- SFC-712 Flow cell holder
- MFC-714 Micro flow cell holder
- FIC-715 Micro flow cell holder
- AWU-828 Washing unit
- Dust Cover

ASU-800 - Autosampler unit



Rack	Tube/Microplate/Vials
6989-J111A – <b>SRA-811</b>	<b>6774-H110A</b>
15 mm O.D. test tube rack - 100 samples	15 mm O.D. test tube, 15 mm (O.D.) x 105 mm (H) - 10 mL - 100 pcs/set
6989-J112A – <b>SRA-812</b>	<b>6774-H109A</b>
13 mm O.D. test tube rack – 100 samples	13 mm O.D. test tube, 13 mm (O.D.) x 100 mm (H) - 7 mL - 100 pcs/set
6989-J113A – <b>SRA-813</b>	<b>6905-H146A</b>
12 mm O.D. test tube rack – 150 samples	12 mm O.D. test tube, 12 mm (O.D.) x 105 mm (H) - 5 mL - 100 pcs/set
6989-J114A – <b>SRA-814</b>	<b>6774-H111A</b>
10 mm O.D. test tube rack – 150 samples	10 mm O.D. test tube, 10 mm (O.D.) x 90 mm (H) - 3 mL - 100 pcs/set
6989-J116A - <b>SRA-816</b> Microplate Rack – 192 samples	Commercially available 1ml 96-well microplates
6989-J117A - SRA-817 Thermostatted Microplate Rack – 192 samples	Commercially available 1ml 96-well microplates
6989-J118A – <b>SRA-818</b>	<b>0410-0102</b>
Vial Rack	Screw top vial – 1.5 mL - 500 pcs./set

**Specifications** 

Nozzle	SUS-316 - 1.5 mm (O.D.) x 1.1 mm (I.D.)
Tubing	Teflon – 2.0 mm (O.D.) x 1.0 mm (I.D.)
Software	Fully controlled by Personal Computer - Included as standard: Spectra Measurement, Quantitative Calibration, Quantitative Analysis and Fixed Wavelenght Measurement
Communication	USB



#### AWU-828 Washing Unit

Washing unit specifically design for the sippers NQF-781, NQF-783 and NPF-782. The AWU-828 can automatically

The AWU-828 can automatically wash the ASU-800 autosampler system.



### Dust cover

This is a dust case that covers the rack part of ASU-800



NQF-781 – Vacuum sipper

#### Specifications

NQF-781 can be used in conjunction with the autosampler ASU-800.

A 10 mm rectangular cell holder is integrated in addition to the 10 mm flow cell, and can be easily switched.

<b>Optical Pathlenght</b>	10 mm
Cell Capacity	about 50 μL
Cell Material	Quartz
Carryover	Less than 1%
Minimum sample requirement	0.7 mL for low-viscosity samples
Material in contact with sample/solvent	Teflon, Fluoroelastomer, Aflon
Maximum Processing Capacity	450 samples/hour
Wavelength Range	220 - 900 nm (V-750/760) 220 - 2200 nm (V-770) 220 - 1600 nm (V-780)



**Specifications** 

NQF-783 can be used in conjunction with the autosampler ASU-800.

NQF-783

Vacuum sipper with long-path flow cell

A 50 mm rectangular cell holder is integrated in addition to the 50 mm flow cell, and can be easily switched.

Optical Pathlenght	50 mm
Cell Capacity	about 1400 μL
Cell Material	Quartz
Carryover	Less than 1%
Minimum sample requirement	2.4 mL for low-viscosity samples
Material in contact with sample/solvent	Teflon, Fluoroelastomer, Aflon
Maximum Processing Capacity	450 samples/hour
Wavelength Range	220 - 900 nm (V-750/760) 220 - 2200 nm (V-770) 220 - 1600 nm (V-780)



NPF-782 – Peristaltic sipper

#### **Specifications**

NPF-782 can be used in conjunction with the autosampler ASU-800. A 10 mm rectangular cell holder is integrated in addition to the 10 mm flow cell, and can be easily switched. The sample can be recovered by reversing the 'drain' direction.

1-780

Optical Pathlenght	10 mm
Cell Capacity	about 50 μL
Cell Material	Quartz
Carryover	Less than 1%
Minimum sample requirement	0.7 mL for low-viscosity samples
Material in contact with sample/solvent	Teflon, Fluoroelastomer, Aflon
Maximum Processing Capacity	360 samples/hour
Wavelength Range	220 - 900 nm (V-750/760) 220 - 2200 nm (V-770) 220 - 1600 nm (V-780)



SFC-712 – Flow cell holder

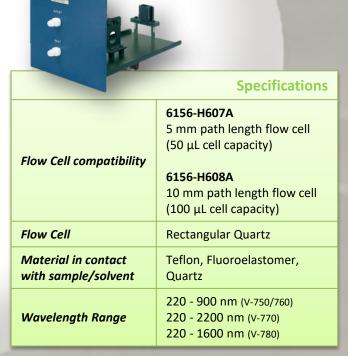
#### ASP-849 – Syringe Pump



#### **Specifications**

The ASP-849 can be used in conjunction with the ASU-800 and SFC-712/MFC-714/FIC-715 flow cell holders. The syringe pump is suitable for drawing small quantities of sample.

Reproducibility of volume delivery	Within $\pm 1\%$
Syringe volume	2.5 mL (included as standard)
Optional syringes	1 mL – 5 mL – 10 mL
Material in contact with sample/solvent	Teflon, Fluoroelastomer, Quartz
Compatible Flow Cell Holders	SFC-712 MFC-714 FIC-715



#### MFC-714– Micro Flow cell holder FIC-715 – Micro Flow cell holder



	Specifications
Cell Material	MFC-714: SUS FIC-715: Teflon
<b>Optical Pathlenght</b>	10 mm
Cell Capacity	20 μL

LFC-713 – Long path flow cell holder

## Specifications

Flow Cell compatibility	6522-J343A 30 mm path length flow cell (approx. 0.6 mL cell capacity) 6522-J333A 50 mm path length flow cell (approx. 1 mL cell capacity) 6522-J243A 100 mm path length flow cell (approx. 2 mL cell capacity)
Flow Cell	Synthetic Fused Silica
Wavelength Range	220 - 900 nm (V-750/760) 220 - 2200 nm (V-770) 220 - 1600 nm (V-780)



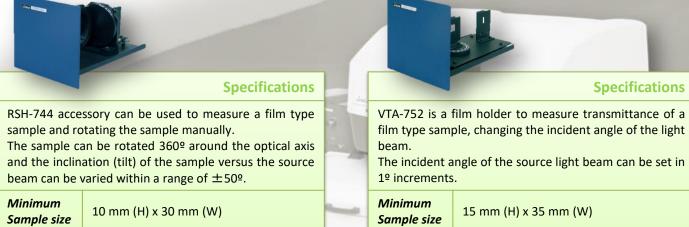
FL	H-740 – Film holder	
FLH-740 accessory are used to measure the transmittance of solid, transparent samples such as films, plate glass, and filters.		
Minimum Sample size	15 mm (H) x 15 mm (W)	
Maximum Sample size	80 mm (H) x 100 mm (W)	
Sample Thickness	0.5 to 10 mm	
Insert Mode	Leaf Spring type	



FLH-741 accessory are used to measure the transmittance of solid, transparent samples such as films, plate glass, and filters.

Minimum Sample size	5 mm (H) x 5 mm (W)
Maximum Sample size	80 mm (H) x 100 mm (W)
Sample Thickness	0.5 to 25 mm
Insert Mode	Holding Plate type

#### RSH-744 – Rotary sample holder



Maximum

Sample

Angle

Thickness Rotation

Sample size

Sample size	10 mm (H) x 30 mm (W)	
Maximum Sample size	18 mm (H) x 38 mm (W)	
Sample Thickness	1 to 2 mm	2
Rotation Angle	Optical axis: 360º Perpendicular to the optical axis: ±50º	

## VTA-752 – Film holder (variable incident angle)

80 mm (H) x 70 mm (W)

1 to 2 mm

±90⁰



#### SLM-907 – Specular Reflectance accessory



#### **Specifications**

SLM-907 accessory is designed to measure the relative reflectance of a sample using the reflected light from an aluminum-deposited plane mirror as a reference.

This accessory allows measurement of the reflectance of metal-deposited films and/or metal Plating, as well as measurement of film thickness using a film thickness analysis program.

Incident angle	Approx. 5º
Minimum Sample size	10 x 10 mm
Maximum Sample size	100 x 120 mm
Beam Port	7 mm diam. (1 mm, 2 mm diam. Options)
Reflection Reference	Aluminum-deposited plane mirror (Standard)
Wavelength range	200 - 870 nm (V-750/760) 200 - 2500 nm (V-770) 200 - 1600 nm (V-780)
Sample chamber lid	Included as standard

Options

	MSK-001	MSK-002	
Sample stage with mask	2 mm diam.	4 mm diam.	
Minimum Sample Size	3 x 3 mm	5 x 5 mm	
Maximum Sample Size	50 x 50 mm 50 x 50 mm		
Suggested Software	VWRR-769 - Reflectance correction program		

#### VWRR-769 Reflectance correction program

VWRR-769 program can convert a relative reflectance spectrum, obtained by using a specular reflectance accessory, to an absolute reflectance spectrum by multiplying the absolute reflectance spectrum of the reflectance standard with a relative reflectance spectrum of the sample.

VWRR-769 software includes typical absolute reflectance data of an evaporated aluminum mirror for conversion.

Required Accessories

SLM-907-SLM-908

#### SLM-908 Specular Reflectance accessory

#### **Specifications**

SLM-908 accessory is designed to measure the relative reflectance of a sample using the reflected light from an aluminum-deposited plane mirror as a reference. This accessory allows measurement of the reflectance of metal-deposited films and/or metal Plating, as well as measurement of film thickness using a film thickness analysis program. SLM-908 accessory can measure larger samples such as 6 inch silicon wafers.

Incident angle	Approx. 5⁰		
Sample size 150 mm diam.			
Beam Port         7 x 7 mm			
Reflection Reference	Aluminum-deposited plane mirror (Standard)		
Wavelength range	200 - 870 nm (V-750/760) 200 - 2500 nm (V-770) 200 - 1600 nm (V-780)		
Sample chamber lid	Included as standard		

Options

	MSK-001	MSK-002
Sample stage with mask	2 mm diam.	4 mm diam.
Minimum Sample Size	3 x 3 mm	5 x 5 mm
Maximum Sample Size	50 x 50 mm 50 x 50 mr	
Suggested Software	VWRR-769 - Reflectance correction program	

#### **DPL-515 – Depolarization Plate**

#### **Specifications**

DPL-515 depolarizer converts incident light to non-polarized light. Non-polarized light is obtained when the rotation angle is set to 45°. The applicable spectral range is from 350 to 2,500 nm.

GPH-506 – Polarizer

#### **Specifications**

GPH-506 polarizer converts the source light from the instrument monochromator into linearly polarized light. The plane of polarization can be set at 0° (vertical linearly polarized light) and 90° (horizontal linearly polarized light). The applicable spectral range is from 215 to 2,300 nm.



ILN-902i - Integrating Sphere, 150 mm

#### ISN-901i - Integrating Sphere, 60 mm



#### **Specifications**

ISN-901i integrating sphere are provided with a light trap so that the reflectance of samples can be measured with or without the specular reflectance component. The rectangular cell holder for diffuse transmittance of a turbid liquid sample and holders for diffuse reflectance of solid samples are standard. A range of sample holders, a fluorescence cut filter and polarizer are available as options.

Inside diameter of integrating sphere	60 mm	
Minimum sample size (Reflectance)	20 (H) x 20 (W) x 0.5 (t) mm	
Maximum sample size (Reflectance)	65 (H) x 50 (W) x 25 (t) mm	
Sample cell (Transmittance)	Rectangular cell 5, 10, 20, 30, 50mm path length	
Reference cell (Transmittance)	Rectangular cell 5, 10, 20 mm path length (Reference cell block is optional)	
Wavelength range	200 – 1600 nm	
On-board Detector	PMT & InGaAs	
Incident angle to reflection surface	0º, approx. 5º	1.1

#### **Options**

**PSH-002 Powder sample holder** - For diffuse reflectance measurements of powder samples - Size of sample area: 16 mm diameter - Thickness: 0.5 - 6 mm

**PSH-003 Powder sample holder** - For diffuse reflectance measurements of small amount of powder samples - Size of sample area: 5 mm diameter - Thickness: 0.5 - 4 mm - (\*) The lens and mask kit is required

#### SSH-506 Solid Sample Holder

For diffuse transmittance measurements of a solid sample Min. sample size: 20 (H) x 20 (W) x 0.5 (t) mm Max. sample size: 70 (H) x 40 (W) x 35 (t) mm

#### RLH-603 Reference Side rectangular cell holder

This cell holder is used for the reference side when performing diffuse transmittance measurements of turbid liquid samples. Cell to be used: 5, 10 or 20 mm optical pathlength rectangular cell

#### (\*) 6916-H123A Lens and mask kit

This accessory kit consists of a lens to focus the light beam onto a small amount of a powder sample and three types of masks (1, 2, 3 mm diam.). The lens focuses the beam down to a 1 mm diameter by using the 1 mm diam. mask for diffuse reflectance measurements of a very small area of the sample.



#### Specifications

**Options** 

ILN-902i integrating sphere are provided with a light trap so that the reflectance of samples can be measured with or without the specular reflectance component. The rectangular cell holder for diffuse transmittance of a turbid liquid sample and holders for diffuse reflectance of solid samples are standard. A range of sample holders, a fluorescence cut filter and polarizer are available as options.

Inside diameter of integrating sphere	150 mm
Minimum sample size (Reflectance)	20 (H) x 20 (W) x 0.5 (t) mm
Maximum sample size (Reflectance)	100 (H) x 50 (W) x 30 (t) mm
Sample cell (Transmittance)	Rectangular cell 5, 10, 20 30, 50 mm path length
Reference cell (Transmittance)	Rectangular cell 5, 10, 20 30, 50 mm path length
Wavelength range	200 – 1600 nm
On-board Detector	PMT & InGaAs
Incident angle to reflection surface	approx. 5º

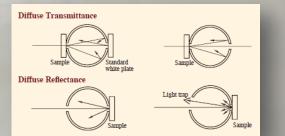
#### PSH-002 Powder sample holder

For diffuse reflectance measurements of powder samples Size of sample area: 16 mm diameter Thickness: 0.5 - 6 mm

#### SSH-507 Solid sample holder

For diffuse transmittance measurements of a solid sample Min. sample size: 20 (H) x 20 (W) x 0.5 (t) mm Max. sample size: 70 (H) x 30 (W) x 40 (t) mm

Integrating spheres are designed to measure either the diffuse transmittance or diffuse reflectance of a sample. Usually, the UV-Vis/NIR spectrophotometers measure the transmittance of a homogeneous, transparent liquid or solid sample. However, when a turbid liquid sample or opaque solid sample is measured, the light incident upon the sample is diffusely transmitted or reflected and only a small portion of the light reaches the detector. The integrating sphere accessory acquires the light diffuse-transmitted or diffusereflected from the sample into the integrating sphere and introduces it to the detector.





IJN-904i Dedicated Gemstone integrating sphere



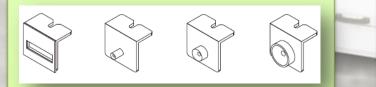
**Specifications** 

IJN-904i is specially designed to measure the diffuse transmittance and diffuse reflectance of small and irregularly shaped samples such as gemstones. Various sample holders are included as standard for measurements of precious stones mounted on rings and necklaces. Use with the GHP-506 polarizer (option) is recommended.

Inside diameter of integrating sphere	60 mm
Minimum sample size (Transmittance/Reflectance)	2 mm diameter
Maximum sample size (Transmittance)	10 mm diameter
Maximum sample size (Reflectance)	30 mm diameter
Wavelength range	250 – 1600 nm
On-board Detector	PMT & InGaAs

Options

Sample holders for rings, pearls, gemstones (included as standard)



#### PIN-903i - Horizontal integrating sphere



PIN-903i can mount samples horizontally and allows the simple measurement of small and powder samples with little to no sample preparation.

Inside diameter of integrating sphere	60 mm
Minimum sample size (Transmittance)	3 mm diam.x 0.5 (T) mm
Maximum sample size (Transmittance)	50 (H) x 50 (W) x 2 (T) mm
Maximum sample size (Reflectance)	30 x 30 x 10 (T) mm
Reflectance measurement adaptor	20 mm diam. x 2 mm (no window required)
Wavelength range	250 – 1600 nm
On-board Detector	PMT & InGaAs

**Options** 

6916-J156A - Lens and mask for reflectance measurement - (mask size: 1, 2 and 3 mm diam.)

6916-J256A - Lens and mask for transmittance measurement - (mask size: 1, 2 and 3 mm diam.)

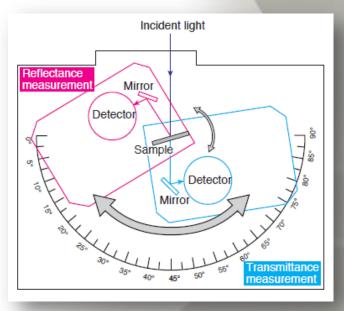
These lens and mask kits are used to focus the light beam for measurement of a small area. When the 1 mm diameter mask is used, the beam diameter of the incident light upon the sample is decreased to a minimum of 2 mm in diameter.



ARMN-921i Automated Absolute Reflectance measurement accessory



	Specifications
Wavelength range	250 – 1600 nm
Movement of sample stage and detector	Asynchronous
Control of sample stage and detector	Automated
Measurement mode	Absolute reflectance Relative reflectance
Integrating sphere	60 mm
	Absolute reflectance mode 5º to 60º
Incidence angle	Relative reflectance mode Vertical incidence
	Transmittance mode 5º to 60º
Angle setting	Sample stage: 0.1º step (manual) Detector stage: 1º step (manual)
Minimum sample size (Absolute Reflectance)	20 (H) x 20 (W) x 1 (t) mm
Maximum sample size (Absolute Reflectance)	70 (H) x 100 (W) x 10 (t) mm
Minimum sample size (Relative Reflectance)	20(H) x 20(W) x 0.5(T) mm
Maximum sample size (Relative Reflectance)	70(H) x 100(W) x 10(T) mm
Accuracy	$\pm$ 1.5% at incidence angle of 6 $^{\circ}$
100% line flatness	Within $\pm 1\%$
Polarizer	Included as standard
Software included	<ul> <li>Absolute reflectance spectral measurement</li> <li>Interval analysis</li> </ul>



The ARMN-921i automates the absolute reflectance measurements of specularly reflecting samples such as metal or glass samples. The detector is equipped with an integrating sphere and thus it also permits measurement of the relative reflectance of a diffusely reflecting sample. Since the angles of the sample stage and the detector can be changed independently, the absolute reflectance and transmittance of a sample can be measured with varied angles of incidence. A software controlled polarizer is provided as standard for the

examination of the polarization properties of a sample. In addition to S and P polarized lights, N polarized light that

obtains the same measurement results as non-polarized light is available.

The interval data analysis program which is standard for the ARMN-920 can display the measurement results in three dimensions of the wavelength, photometric value and angle.



Integrating sphere

Sample Stage



ARN-915i Absolute Reflectance measurement accessory (Synchronous type) ARSN-918i Absolute Reflectance measurement accessory (Asynchronous type)

#### **Specifications**

The ARN-915i accessory provides absolute reflectance measurements of samples by the manual, synchronous movement of the sample stage and detector.

Changing the incident angle of the sample by manually moving the detector position, the absolute reflectance of the sample can be measured at varied incident angles.

Using the optional ARG-476 or GPH-506 polarizers, the polarization properties of the sample can also be examined.

Wavelength range	250 – 1600 nm	
Movement of sample stage and detector	Synchronous	1
Control of sample stage and detector	Manual	
Measurement mode	Absolute reflectance Relative reflectance	
Integrating sphere	60 mm	
Incidence angle	Absolute reflectance mode 5º to 60º	9
incluence ungle	Relative reflectance mode Vertical incidence	
Angle setting	2.5º step (manual)	
Minimum sample size (Absolute Reflectance)	20 (H) x 20 (W) x 1 (t) mm	
Maximum sample size (Absolute Reflectance)	70 (H) x 100 (W) x 10 (t) mm	
Minimum sample size (Relative Reflectance)	20(H) x 20(W) x 0.5(T) mm	
Maximum sample size (Relative Reflectance)	70(H) x 100(W) x 10(T) mm	
Accuracy	$\pm$ 1.5% at incidence angle of 6 $^\circ$	See
100% line flatness	Within $\pm 1\%$	
Polarizer	Optional (ARG-476 or GPH-506)	

APSN-918i accessory provides absolute reflectance

The ARSN-918i accessory provides absolute reflectance measurements of samples by the manual, asynchronous movement of the sample stage and detector, thus, the positions of the sample stage and detector can be independently varied to obtain the absolute reflectance and transmittance spectra of the sample at varied incident and detection angles.

Using	the	optional	ARG-476	or	GPH-506	polarizers,	the
polariz	ation	propertie	s of the sa	mple	e can also l	pe examined	

Wavelength range	250 – 1600 nm
Movement of sample stage and detector	Asynchronous
Control of sample stage and detector	Manual
Measurement mode	Absolute reflectance Relative reflectance
Integrating sphere	60 mm
	Absolute reflectance mode 5º to 60º
Incidence angle	Relative reflectance mode Vertical incidence
	Transmittance mode 5º to 60º
Angle setting	Sample stage: 0.1º step (manual) Detector stage: 1º step (manual)
Minimum sample size (Absolute Reflectance)	20 (H) x 20 (W) x 1 (t) mm
Maximum sample size (Absolute Reflectance)	70 (H) x 100 (W) x 10 (t) mm
Minimum sample size (Relative Reflectance)	20(H) x 20(W) x 0.5(T) mm
Maximum sample size (Relative Reflectance)	70(H) x 100(W) x 10(T) mm
Accuracy	$\pm$ 1.5% at incidence angle of 6 $^\circ$
100% line flatness	Within ±1%
Polarizer	Optional (ARG-476 or GPH-506)



## Absolute Reflectance accessories

#### Options

#### SSH-508 Solid sample holder

The SSH-508 is set on the entrance to the detector for diffuse transmittance measurements of scattering samples at a vertical (0<sup>o</sup>) incidence.

Minimum sample size	30(H) x 30(W) x 0.5(T) mm	
Maximum sample size	70(H) x 80(W) x 10(T) mm	

#### Wide incident angle sample holder

This sample holder is attached to the sample stage to allow an angle of incidence up to a maximum of 85<sup>o</sup>.

- 6708-H163A for ARV and ARSV
- 6708-H460A for ARMV

ARV Minimum sample size	30(H) x 60(W) x 1(T) mm
ARSV - ARMV Minimum sample size	30(H) x 30(W) x 1(T) mm
Maximum sample size	70(H) x 100(W) x 10(T) mm
Incidence angle	0º - 85º

#### PDU-755 Phase difference measurement unit

PDU-755 option provides the measurement of the reflectance phase difference and the transmittance phase difference. It consists of an angle selective analyzer and the VWAP-794 phase difference measurement program (included)

Wavelength range 250 – 20	
Polarization rotation angle0° - 90°	

#### **ARG-476** Polarizer

The ARG-476 is a Glan-Taylor polarizer and is recommended for absolute reflectance measurements using incident angles of 30° or greater. By setting the polarizer at 45°, the same result can be obtained as for measurements with non-polarized light.

Wavelength range	250 – 2000 nm
Polarization rotation angle	0º - 90º

#### Absolute Reflectance accessories Softwares

#### VWAP-794

1-780

#### Phase difference measurement program

VWAP-794 software is included in the PDU-755 phase difference measurement accessory as standard. VWAP-794 program measures transmittance and reflectance phase difference spectra with multiple

incident angles by using a polarizer and analyzer.



#### FAN-751 - Optical fiber unit



#### **Specifications**

FAN-751 accessory consisting of an optical fiber unit and external detector, enables the measurement of bulky samples that cannot be set in the sample compartment and/or samples that are in special environments. The light from the main instrument is introduced to the optical fiber. The light from a sample is introduced to the external detector via the optical fiber.

External detector	Photomultiplier tube
Wavelength range	250 – 1600 nm

**Options** 

1-780

#### 6916-J254A

Fiber connection port, Bundle type for FAN-751

#### 6916-J250A

Fiber connection port, FC connector type for FAN-751

#### 6916-J251A

Fiber connection port, SMA connector type for FAN-751

#### ELM-912 - External light source interface



This interface is for introducing light from an external light source into the spectrophotometer, and measuring the spectrum of the external source. It can be used for the spectral/intensity evaluation of external light sources.

\* For correction of the measured spectrum, a secondary reference source is also required.

**Options** 

**1120-0109** - Optical fiber (bundle type), 1m **1120-0110** - Optical fiber (bundle type), 1.5m FAP-754 - Optical fiber unit



#### Specifications

FAP-754 accessory can be used for sample measurement using the internal detector of the spectrophotometer. The light from the main instrument is introduced to an optical fiber. The light from a sample is introduced to the detector of the spectrophotometer via a return optical fiber.

Options

**6916-J154A** Fiber connection port, Bundle type for FAP-754

**6916-J150A** Fiber connection port, FC connector type for FAP-754

**6916-J151A** Fiber connection port, SMA connector type for FAP-754

# V-780-CFR – Additional Software Packages

### **Biochemical Softwares**

#### VWKN-772 Kinetics analysis program

VWKN-772 Kinetics Analysis program performs time course measurements of multiple samples, plots the graphs and calculates the maximum reaction velocity (Vmax), Michaelis Menten constant (Km) and the Hill constant (n).

The program also supports calculation of inhibitor constant and determination of inhibitor type by comparing data obtained with and without an inhibitor. An automated cell changer can be utilized, enabling batch analysis of multiple data.

Five types of plots

- Michaelis-Menten
- Lineweaver-Burk
- Hofstee
- Eadie
- Hill

#### Calculation items

- Maximum reaction velocity (Vmax)
- Michaelis-Menten constant (Km)
- Hill constant (n)
- determination of inhibitor type
- inhibitor constant

CFR compliant YES

#### VWPN-952 Protein nucleic acid quantitation program

VWPN-952 program measures the absorbance of protein and nucleic acid solutions at specified wavelengths and calculates the concentration of the protein and nucleic acids based on a calculation method selected from five different types listed below. It is possible to select the wavelength for baseline correction and to choose whether baseline correction is to be performed. Generally, correction is performed for turbid solutions at a wavelength of 320 nm. Dilution rate correction is also possible for the user-defined concentration calculation method.

Available calculation methods

- Absorbance ratio of 280/260 nm
- Absorbance ratio of 230/260 nm
- Warburg-Christian method
- User-defined absorbance ratio
- User-defined concentration calculation

#### *VWTP-959*

## Temperature Gradient measurement and DNA melting analysis program

VWTP-959 temperature programming software offers DNA or protein melting analysis.

Controlling the temperature of a Peltier accessory (single or multi-cell), the VWTP-959 provides measurement of the absorbance at a specific wavelength during temperature changes, then calculates the melting temperature (Tm) from the results of the measurement.

Suggested	EHCS -760 - ETCS-761 – ETCR-762
Accessories	PSC-763 - PAC-743
CFR compliant	YES

#### VWIS-957

#### Interval scan measurement program

VWIS-957 program measures spectra of samples automatically with a user-defined time interval between scans. The final data array can be displayed as a 2-D spectral display; a 3-D spectral display; contour, colorimage or cross-section images; or 2-D displays of the peak height/ratio, peak area/ratio, FWHM or peak shift calculations. Data plots similar to the VWIS-957 software can be obtained using the VWTS-958 data array.

VWIS-957 can be used with an automated cell changer accessory for spectral data collection of multiple samples.

Suggested Accessories	NCP-705	
CFR compliant	YES	

#### VWIS-958

## Temperature interval scan measurement program

VWTS-958 program measures spectra of samples automatically with a user-defined temperature interval between scans, providing a data array similar to the VWIS-957 program, but related to sample temperature. VWTS-958 can be used with an automated cell changer and/or with Thermostatted Single or Multiple holders for spectral data collection of multiple samples.

Suggested Accessories	NCP-705 EHCS -760 - ETCS-761 - ETCR-762 PSC-763 - PAC-743
CFR compliant	YES

## V-780-CFR – Biochemical Package



### **Biochemical Package**

#### VWKN-772 Kinetics analysis program

VWKN-772 Kinetics Analysis program performs time course measurements of multiple samples, plots the graphs and calculates the maximum reaction velocity (Vmax), Michaelis Menten constant (Km) and the Hill constant (n).

The program also supports calculation of inhibitor constant and determination of inhibitor type by comparing data obtained with and without an inhibitor. An automated cell changer can be utilized, enabling batch analysis of multiple data.

Five types of plots

- Michaelis-Menten
- Lineweaver-Burk
- Hofstee
- Eadie
- Hill

#### Calculation items

- Maximum reaction velocity (Vmax)
- Michaelis-Menten constant (Km)
- Hill constant (n)
- determination of inhibitor type
- inhibitor constant

CFR compliant YES

#### UCB-710 – Bio rectangular cell holder



A cell height adjustment function provides the ability to use a 100  $\mu$ L micro cell. A mask for a 100  $\mu$ L micro cell is standard, 50  $\mu$ L can be supplied as option.

Sample Cell	Rectangular cell pathlength 10 mm	
Reference Cell	Rectangular cell pathlength 10 mm	
Capacity	1 sample and 1 reference cell	
Temperature	Ambient	
Minimum Cell Volume	50 μL	

#### **VWTP-959**

## Temperature Gradient measurement and DNA melting analysis program

VWTP-959 temperature programming software offers DNA or protein melting analysis.

Controlling the temperature of a Peltier accessory (single or multi-cell), the VWTP-959 provides measurement of the absorbance at a specific wavelength during temperature changes, then calculates the melting temperature (Tm) from the results of the measurement.

Suggested	EHCS -760 - ETCS-761 – ETCR-762
Accessories	PSC-763 - PAC-743
CFR compliant	YES

#### VWPN-952

#### Protein nucleic acid quantitation program

VWPN-952 program measures the absorbance of protein and nucleic acid solutions at specified wavelengths and calculates the concentration of the protein and nucleic acids based on a calculation method selected from five different types listed below. It is possible to select the wavelength for baseline correction and to choose whether baseline correction is to be performed. Generally, correction is performed for turbid solutions at a wavelength of 320 nm. Dilution rate correction is also possible for the user-defined concentration calculation method.

#### Available calculation methods

- Absorbance ratio of 280/260 nm
- Absorbance ratio of 230/260 nm
- Warburg-Christian method
- User-defined absorbance ratio
- User-defined concentration calculation

**CFR compliant** YES

6916-J310A – Bio-Package for V-700 series		
Part Number	Model	Description
6916-H110A		Bio cell holder block (sample side cell block of UCB-710) including Mask for 100uL micro cell
4880-7472A	VWKN-772	Advanced kinetics analysis program
4880-6522A	VWTP-959	Temperature gradient measurement and DNA melting analysis program
4880-6515A	VWPN-952	Protein nucleic acid quantitation program

# **Usco** *Europe* V-780-CFR – Additional Software Packages

### **Materials Analysis Softwares**

V-780

#### VWQM-978

#### Spectrum quantitative measurement program

VWSQ-978 package provides the quantitative analysis for a maximum of ten peaks by applying the Beer-Lambert law to each selected sample peak. Simultaneous determination of multiple components of a sample is possible if the absorption peaks of each component do not overlap. Two calculation methods are available, using either the peak height or peak area of the selected absorption peaks.

## Spectra Manager Ver.? Dectra Manager Ver.?



## JASCO Europe S.r.l.

Via Cadorna, 1 - 23894 Cremella (LC)

jasco@jasco-europe.com

www.jasco-europe.com

Follow us on: Linked in

#### DISCLAIMER

The contents of this publication are for reference and illustrative purposes only. Information, descriptions, and specifications in this document are subject to change without notice and cannot be used from third parts for data comparison and/or performance comparison. JASCO assumes no responsibility and will not be liable for any errors or omissions contained herein or for incidental, consequential damages or losses in connection with the furnishing, performance or use of this material.